Notice of References Cited

Application/Control No. 09/838,801	Reexamination	Applicant(s)/Patent Under Reexamination BERK ET AL.		
Examiner	Art Unit			
Thomas H. Stevens	2123	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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	Ε	US-			
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FOREIGN PATENT DOCUMENTS

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	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	MODTRAN: A Moderate Resolution Model for LOWTRAN; Berk et al., Spectral Sciences Inc., Burlington, MA Technical Report 12 May 1986 – 11 May 1987, abstract, pg.1-2.
	٧	Halthore et al., "Models Overestimate Diffuse Clear-Sky Surface Irradiance: A Case for Excess Atmospheric Absorption" 1998 Spectral Science pg. 3591-3594.
	w	Berk et al., "Reformulation of the MODTRAN Band Model for Higher Spectral Resolution". April 2000, pg. 1-10.
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.